

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors:

Blaine R. Spady; John D. Heaton

Assignee:

Nanometrics Incorporated

Title:

Metrology/Inspection Positioning System

Serial No.:

09/458,123

Filing Date:

December 8, 1999

Examiner:

Gordon Stock

Group Art Unit:

2877

Docket No.:

NAN035 US

Confirmation No.:

8470

Santa Clara, California November 15, 2005

Mail Stop Amendment Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

RESPONSE TO OFFICE ACTION

Dear Sir:

This Response to Office Action is responsive to the June 15, 2005, Office Action, which has a statutorily shortened period for response that ends September 15, 2005. A petition for a two month extension is attached hereto, giving Applicant until November 15, 2005, to respond. Please enter the following amendments before taking action on the merits of the above-referenced application.

SILICON VALLEY
PATENT GROUP LLP

2350 Mission College Blvd. Suite 360 Santa Clara, CA 95054 (408) 982-8200 FAX (408) 982-8210